

Notice of References Cited	Application/Control No. 10/634,385	Applicant(s)/Patent Under Reexamination IKEDA ET AL.	
	Examiner Hoang V Nguyen	Art Unit 2821	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0118140 A1	08-2002	Ogawa et al.	343/834
	B	US-6,181,286 B1	01-2001	Roscoe et al.	343/725
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NON-PATENT DOCUMENTS

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